## WHAT IS CLAIMED IS:

- 1. A PIN photodiode comprising:
- a first conductive-type semiconductor substrate;
- an intrinsic semiconductor layer and a second conductive-type semiconductor layer formed on the first conductive-type semiconductor substrate in sequence;
  - a first insulation layer formed on the second conductive-type semiconductor layer, in which a window is formed in the center part of the first insulation layer so that the intrinsic semiconductor layer is exposed;
- a second-conductive type active layer formed on the intrinsic semiconductor layer within the window;
  - a first electrode formed on the first insulation layer in contact with the second conductive-type active layer; and,
- a gate electrode structure consisting of a second insulation layer and a second electrode formed on the second conductive-type semiconductor layer and for applying an electric voltage of a second polarity, so that the lateral extension of the active layer is controlled at the time when an electric voltage of a first polarity is applied to the first electrode formed on the first insulation layer.
- 2. The PIN photodiode according to claim 1, further comprising an anti-reflection layer formed on the active layer within the window.

3. The PIN photodiode according to claim 1, wherein the first insulation layer is formed to such a thickness that the first electrode and the second electrode are electrically isolated from each other without being overlapped between the crossed portions of the first electrode and the second electrode.

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- 4. The PIN photodiode according to claim 1, wherein the second insulation layer is formed to such a thickness that it can effectively transfer the electric field applied to the second electrode to the active layer.
- 5. The PIN photodiode according to claim 1, wherein the second conductive-type active layer is a P+ active layer.
  - 6. The PIN photodiode according to claim 1, wherein the electric voltage of the first polarity is negative voltage.

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- 7. The PIN photodiode according to claim 1, wherein the electric voltage of the second polarity is positive voltage.
- 8. The PIN photodiode according to claim 1, wherein the thickness of the first 20 insulation is substantially greater than the second electrode.